

10-Bit Digital-to-Analogue Converter

Description

The WM5615 is a 10-bit voltage output digital-toanalogue converter (DAC) with a buffered reference input (high impedance). The DAC produces a maximum output voltage that is twice the reference voltage and the DAC is monotonic. The device is simple to use, running from a single supply of 5V. A power-on reset function is incorporated to ensure repeatable start-up conditions.

Digital control of the WM5615 is over a 3-wire serial bus that is CMOS compatible and easily interfaced to industry standard microprocessor and microcontroller devices. The device receives a 16-bit data word to produce the analogue output. The digital inputs feature Schmitt triggers for high noise immunity. Digital communication protocols include the SPI™, QSPI™ and Microwire[™] standards.

The 8-terminal small-outline D package allows digital control of analogue functions in space-critical applications. The WM5615C is characterised for operation from 0° C to 70°C. The WM5615I is for operation from -40°C to 85°C.

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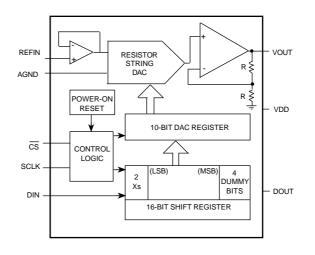
Features

- 10-bit CMOS voltage output DAC in an 8-terminal package
- 5V single supply operation
- 3-wire serial interface
- High-impedance reference input
- Maximum voltage output twice reference input voltage
- Internal power-on reset
- Low power consumption ... 1.75mW max
- 877kHz update rate
- Setting time to 0.5 LSB ... 12.5µs typical
- Monotonic over temperature
- Pin compatible with the Maxim MAX515

Applications

- Battery-powered test Instruments
- Digital offset and gain adjustment
- Battery-operated/remote industrial controls
- Machine and motion control devices
- Cellular telephones

Block Diagram

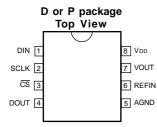


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Wolfson Microelectronics

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Pin Configuration



Ordering Information

DEVICE	TEMP RANGE	PACKAGE
WM5615CD	0°C to +70°C	8 pin SO
WM5615CP	0°C to +70°C	8 pin DIP
WM5615ID	-40°C to +85°C	8 pin SO
WM5615IP	-40°C to +85°C	8 pin DIP

Absolute Maximum Ratings

Operating free-air temperature range TA:
WM5615C 0°C to +70°C
WM5615I
Storage temperature range Tstg65°C to +150°C
Lead temperature 1.6mm (1/16 inch)
from case for 10 seconds

Note: Stresses beyond those listed under 'Absolute Maximum Ratings' may cause damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under 'Recommended Operating Conditions' is not implied. Exposure to absolute maximum rated conditions for extended periods may affect device reliability.

Recommended Operating Conditions

PARAMETER		SYMBOL	MIN	ТҮР	MAX	UNIT
Supply voltage		Vdd	4.5	5	5.5	V
High-level digital input voltage		Viн	2.4			V
Low-level digital input voltage		VIL			0.8	V
Reference voltage to REFIN terminal		Vref	0	2.048	Vdd-2	V
Load resistance		RL	2			kΩ
Operating free air temperature	WM5615C	TA	0		70	Ĉ
	WM5615I	TA	-40		85	°C

Electrical Characteristics (over recommended operating free-air temperature range)

VDD = $5.0V \pm 5\%$, Vref = 2.048V unless otherwise stated.

Static DAC Specifications

PARAMETER	SYMBOL	(CONDITIONS	MIN	TYP	MAX	UNIT
Resolution				10			bits
Integral nonlinearity	INL	(see no	te 1)			±1	LSB
Differential nonlinearity	DNL	(see no	te 2)		+0.1	±0.5	LSB
Zero scale error (offset error)	Ezs	(see no	te 3)			±3	LSB
Zero scale error (offset error)		(see no	te 4)		3		ppm/ºC
temperature coefficient							
Gain error	Eg	(see no	te 5)			±3	LSB
Gain error temperature		(see no	te 6)		1		ppm/ºC
coefficient							
Power-supply rejection ratio	PSRR	Offset	(see notes 7 and 8)		0.1		LSB/V
-		Gain			0.1]
Analogue full scale output		RL = 100	ĴkΩ	2V	ref(1023/10)24)	V

Notes:

- The relative accuracy or integral nonlinearity (INL), sometimes referred to as linearity error, is the maximum deviation ot the output from the line between zero and full scale, excluding the effect of zero code and full scale errors (see text).
- 2. The differential nonlinearity (DNL), sometimes referred to as differential error, is the difference between the measured and ideal LSB amplitude change of any two adjacent codes. Monotonic means the output voltage changes in the same direction (or remains constant) as a change in the digital input code.
- 3. Zero-scale error is the deviation from zero voltage output when the digital input is zero (see text)
- Zero-scale error temperature coefficient is given by Ezs TC = [Ezs (Tmax) - Ezs (Tmin)] /Vref x 10⁶/ (Tmax-Tmin)

- 5. Gain error is the deviation from the ideal output (Vref 1LSB) with an output load of $10k\Omega$, excluding the effects of zero error.
- Gain temperature coefficient is given by EG TC = [EG (Tmax) - EG (Tmin)] /V ref x 10⁶/(Tmax-Tmin).
- Zero-scale offset error rejection ratio (Ezs-RR) is measured by varying the VDD from 4.5V to 5.5V DC and measuring the proportion of this signal imposed on the zero-code output voltage.
- Gain error rejection ratio (EG-RR) is measured by varying the VDD from 4.5 to 5.5 V DC and measuring the proportion of this signal imposed on the full-scale output voltage after subtracting the zero scale change.

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
Voltage output range	Vo	RL=10kΩ	0		Vdd-0.4	V
Output load regulation accuracy		$Vo(OUT) = 2V RL=2k\Omega$			0.5	LSB
Output short circuit current	losc	OUT to VDD or AGND		20		mA
Output voltage, low level	VOL(low)	lo (OUT) <= 5mA			0.25	V
Output voltage, high level	VOH(high)	lo (OUT) <= -5mA	4.75			V

Voltage Output (OUT)

Electrical Characteristics (continued)

VDD = 5.0V \pm 5%, Vref = 2.048V unless otherwise stated.

Reference Input (REFIN)

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNIT
Input voltage range	Vi		0		Vdd-2	V
Input resistance			10			MΩ
Input capacitance	Ci			5		pF

Digital Inputs (DIN, SCLK, CS)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
High level digital input voltage	Viн		2.4			V
Low level digital input voltage	VIL				0.8	V
High level digital input current	Ін	VI = VDD			±1	μA
Low level digital input current	lı.	$V_{I} = 0V$			±1	μA
Input capacitance	Ci			8		pF

Digital Output (DOUT)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
Output voltage high	Vон	Io = -2mA	Vdd-1			V
Output voltage low	Vol	Io = 2mA			0.4	V

Power Supply

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNIT
Supply voltage	Vdd		4.5	5	5.5	V
		VDD = 5.5V, no load. Vref = 0V		150	250	μA
Power supply current	IDD	All inputs = 0V or VDD				
		VDD = 5.5V, no load. Vref = 2.048	V	230	350	μA
		All inputs = 0V or VDD				

Electrical Characteristics (continued)

VDD = 5.0V \pm 5%, Vref = 2.048V unless otherwise stated.

Analogue Output Dynamic Performance

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
Output slew rate	SR	$CL = 100 pF RL = 10 k\Omega$	0.3	0.5		V/µs
		$T_A = 25^{\circ}C$				
Output settling time	ts	To 0.5 LSB CL = 100pF		12.5		μs
		$RL = 2k\Omega$ (see note 9)				
Glitch energy		DIN = All 0s to all 1s		5		nV∎s
Signal to noise + distortion	S/(N+D)	Vref = 2Vpp at 1kHz +		60		dB
		2.048 V DC, code 512				

Note 9: Settling time is the time for the output signal to remain within 0.5 LSB of the final measured value for a digital input code change from code zero to 1023 rising and 1023 to 64 falling.

Digital Input Timing Specifications

PARAMETER	SYMBOL	MIN	TYP	MAX	UNIT
Setup time, DIN before SCLK high	tsu (DS)	45			ns
Hold time, DIN valid after SCLK high	th (DH)	0			ns
Setup time, CS low to SCLK high	tsu (CSS)	1			ns
Setup time CS high to SCLK high	tsu (CS1)	50			ns
Hold time, SCLK low to CS low	th (CSHO)	1			ns
Hold time, SCLK low to CS high	th (CSHI)	0			ns
Pulse duration, min. chip select pulse width height	tw(CS)	20			ns
Pulse duration, SCLK low	tw (CL)	18			ns
Pulse duration, SCLK high	tw (CH)	18			ns

Output Switching Specification

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNIT
Propagation delay time	tpd (DOUT)	CL = 50pF			50	ns

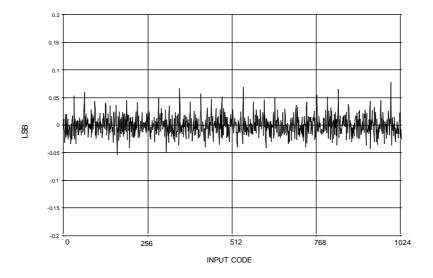
reference input (REFIN)

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
Reference feedthrough	Input code = 00		-80		dB
	(see note 10)				
Reference input bandwidth	Input code = 512		100		kHz
	(see note 10)				

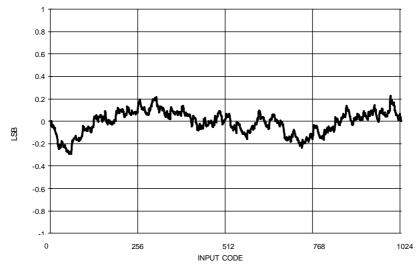
Note 10: Reference feedthrough and bandwidth are measured at the DAC output with Vref input = 2Vpp at 1kHz + 2.048V DC

WM5615

Typical Performance Characteristics





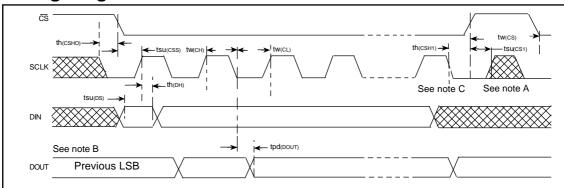




Pin Description

PIN	NAME	FUNCTION
1	DIN	Serial data input.
2	SCLK	Serial clock input.
3	CS	Chip select, active low.
4	DOUT	Serial data output for daisy-
		chaining.
5	AGND	Analogue ground.
6	REFIN	Reference input.
7	VOUT	DAC output.
8	VDD	Positive power supply.

Timing Diagram



NOTES: A. The input clock, applied at the SCLK terminal, should be inhibited low when CS is high to minimise clock feedthrough. B. Data input from preceding conversion cycle.

C. Sixteenth SCLK falling edge.

Detailed Description

General Function

The WM5615 uses a resistor string network buffered with a single-supply CMOS op amp in a fixed gain of x2 to convert 10-bit digital data to analogue voltage levels (see Block Diagram). The topology of the WM5615 makes the output the same polarity as the reference input (see Table 1).

An internal reset circuit forces the DAC register to reset to all 0s on power-up.

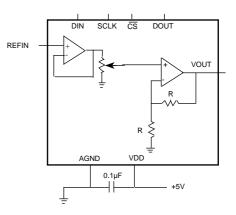


Figure 1 - Typical Operating Circuit

Detailed Description (Continued)

Table 1 - Binary Code Table(0V to 2VREFIN Output), Gain = 2

INPUT*			OUTPUT
1111	1111	11 (xx)	+2(V _{REFIN}) 1023 1024
1000	0000	01 (xx)	+2(V _{REFIN}) 513 1024
1000	0000	00 (xx)	+2(V_{REFIN}) $\frac{512}{1024}$ = V_{REFIN}
0111	1111	11 (xx)	+2(V _{REFIN}) 511 1024
0000	0000	01 (xx)	+2(V _{REFIN}) 1/1024
0000	0000	00 (xx)	0V

* A 10-bit data word with two sub-LSB Xs must be written since the DAC input latch is 12-bits wide.

Buffer Amplifier

The output buffer is a rail-to-rail output CMOS op amp. Max. setting time is 12.5µs to +/-0.5 LSB of final value. The output is short-circuit protected and can drive a $2k\Omega$ load with a 100pF load capacitance.

External Reference

The external voltage input is buffered and must be positive but less than VDD - 2V. The reference voltage determines the DAC full-scale output. Since the reference terminal is buffered, the DAC input resistance is not code dependent and is $10M\Omega$ minimum. The REFIN input capacitance is typically 5pF.

Digital Interface

The digital inputs are designed to be compatible with TTL or CMOS logic levels. However, to achieve the lowest power dissipation, the digital inputs should be driven with rail-to-rail CMOS logic. With TTL logic levels, the power requirement increases by a factor of approximately two.

Serial Interface

The WM5615 uses a three-wire serial interface which is compatible with SPI, QSPI (CPOL = CPHA = 0) and Microwire standards as shown in figures 2 and 3. The DAC is programmed by writing two 8-bit words, MSB first (see Block Diagram and Timing Diagram). 16 bits of serial data are clocked into the DAC in the following order, 4 fill (dummy) bits, 10 data bits and 2 sub-LSB Xs. The 4 dummy bits are not normally needed and are required only when DACs are daisy chained. The 2 sub-LSB Xs, however, are always needed because the input register is 12 bits wide. Transitions at CS should occur while SCLK is low. Data is clocked in on the SCLK rising edge while \overline{CS} is low. The serial input data is held in a 16bit serial shift register. On the \overline{CS} rising edge, the ten data-bits are transferred to the DAC register and update the DAC. With CS high, data cannot be clocked into the DIN terminal.

The WM5615 receives data in 16-bit blocks. The SPI and Microwire interfaces output data in 8-bit blocks requiring two write cycles to input data to the DAC. The QSPI interface allows variable data output from 8 to 16 bits so can load into the DAC in one write cycle.

Detailed Description (Continued)



Figure 2 - Microwire Connection



Note: The DOUT-MISI connection is not required for writing to the WM5615, but may be used for verifying data transfer.

Daisy-Chaining Devices

The serial output, DOUT, allows cascading of two or more DACs. The data at DIN appears at DOUT, delayed by 16 clock cycles plus one clock width. For low power, DOUT does not require an external pull-up resistor. DOUT does not go into a high-impedance state when \overrightarrow{CS} is high. DOUT changes on SCLK's falling edge when \overrightarrow{CS} is low. When \overrightarrow{CS} is high, DOUT remains in the state of the last data bit.

Any number of DACs can be daisy-chained by connecting the DOUT of one device to the DIN of the next device in the chain.

Linearity, Offset and Gain Error using Single End Supplies

When an amplifier is operated from a single supply, the voltage offset can still be either positive or negative. With a positive offset, the output voltage changes on the first code change. With a negative offset, the output voltage may not change with the first code depending on the magnitude of the offset voltage.

The output amplifier, with a negative voltage offset, attempts to drive the output to a negative voltage. However, because the most negative supply rail is ground, the output cannot drive to a negative voltage. So when the output offset voltage is negative, the output voltage remains at zero volts until the input code value produces a sufficient output voltage to overcome the inherent negative offset voltage, resulting in the transfer function shown in figure 4.

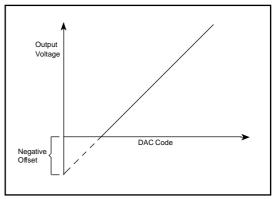


Figure 4 - Effect of Negative Offset (Single Supply)

This negative offset, not the linearity error, produces this breakpoint. The transfer function would have followed the dotted line if the output buffer could drive to a negative voltage.

For a DAC, linearity is measured between zero input code (all inputs 0) after offset and full-scale are adjusted out or accounted for in some way. However, single supply operation does not allow for adjustment when the output is negative due to the breakpoint in the transfer function. So the linearity is measured between the full-scale and the lowest code which produces a positive output voltage. For the WM5615, the zero scale (offset) is plus or minus 3LSB maximum. The code is calculated from the maximum specification for the negative offset.

Detailed Description (Continued)

Power-Supply Bypassing and Ground Management

Best system performance is obtained with printed-circuit boards that use separate analog and digital ground planes. Wire-wrap boards are not recommended. The two ground planes should be connected together at the lowimpedance power-supply source. The best ground connection may be achieved by connecting the DAC AGND terminal to the system analogue ground plane.

VDD should be bypassed with a 0.1μ F ceramic capacitor connected between VDD and AGND. It should be mounted with short leads close to the device. Ferrite beads may be used to further isolate the system analogue and digital power supplies.

Figure 5 illustrates the grounding and bypassing scheme described.

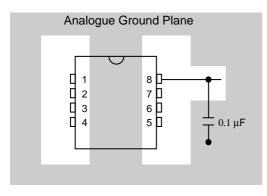


Figure 5 - Power-Supply Bypassing

Saving Power

When the DAC is not being used by the system, minimize power consumption by setting the appropriate code to minimize load. For example, with a resistive load to ground, set the DAC code to 0 (see Table 1). In addition, the REFIN buffer has to drive current into the DAC resistor string and so setting REFIN to 0 further reduces power consumption.

Analogue Feedthrough

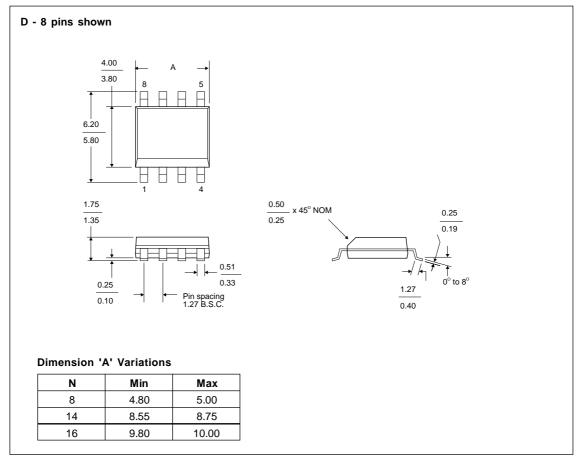
Because of internal stray capacitance, higher frequency analog input signals may couple to the output. this is tested by holding CS high, setting the DAC code to all 0s and sweeping REFIN.

Digital Feedthrough

High-speed serial data at any of the digital input or output pins may couple through the DAC package internal stray capacitance to appear at the DAC output as noise, even though \overrightarrow{CS} is held high. This digital feedthrough is tested by holding \overrightarrow{CS} high while transmitting 1010... from DIN to DOUT.

Package Descriptions

Plastic Small-Outline Package

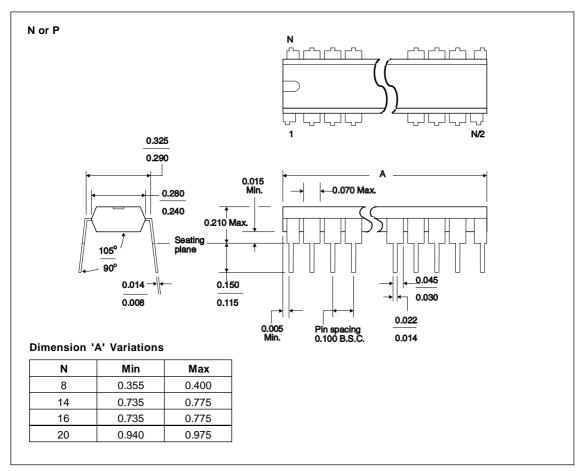


Notes:

- A. Dimensions in millimeters.
- B. Complies with Jedec standard MS-012.
- C. This drawing is subject to change without notice.
- D. Body dimensions do not include mold flash or protrusion.
- E. Dimension A, mould flash or protrusion shall not exceed 0.15mm. Body width, interlead flash or protrusions shall not exceed 0.25mm.

Package Descriptions

Dual-In-Line Package



Notes:

- A. Dimensions are in inches
- B. Falls within JEDEC MS-001(20 pin package is shorter than MS-001)
- C. N is the maximum number of terminals
- D. All end pins are partial width pins as shown, except the 14 pin package which is full width.